

Smart High-Side Power Switch

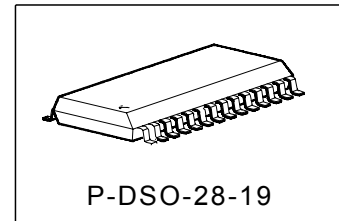
Four Channels: 4 x 25mΩ

IntelliSense

Product Summary

Operating voltage	$V_{bb(on)}$	4,5...28 (Loadump: 40 V)		V
Active channels		one	four parallel	
On-state resistance	R_{ON}	25	6.5	mΩ
Nominal load current	$I_{L(nom)}$	6.2	13.9	A
Current limitation	Low	$I_{L(SCr)}$		10 A
	High			40

Package



General Description

- N channel vertical power MOSFET with charge pump, ground referenced CMOS compatible input and diagnostic feedback, monolithically integrated in Smart SIPMOS® technology.
- Providing embedded protective functions.
- Extern adjustable current limitation.

Application

- All types of resistive, inductive and capacitive loads
- µC compatible high-side power switch with diagnostic feedback for 12 V grounded loads
- Due to the adjustable current limitation best suitable for loads with high inrush currents, so as lamps
- Replaces electromechanical relays, fuses and discrete circuits

Basic Functions

- Very low standby current
- CMOS compatible input
- Improved electromagnetic compatibility (EMC)
- Stable behaviour at low battery voltage

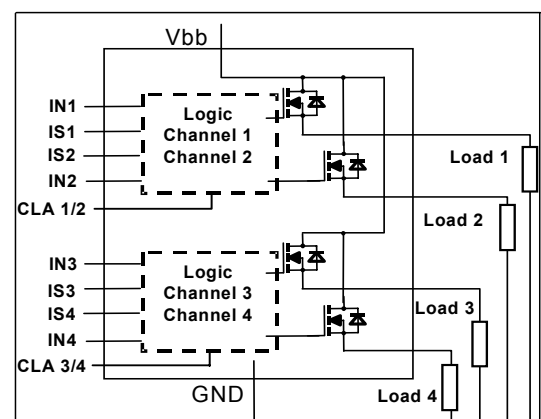
Protection Functions

- Reverse battery protection with external resistor
- Short circuit protection
- Overload protection
- Current limitation
- Thermal Shutdown
- Overvoltage protection with external resistor
- Loss of GND and loss of V_{bb} protection
- Electrostatic discharge Protection (ESD)

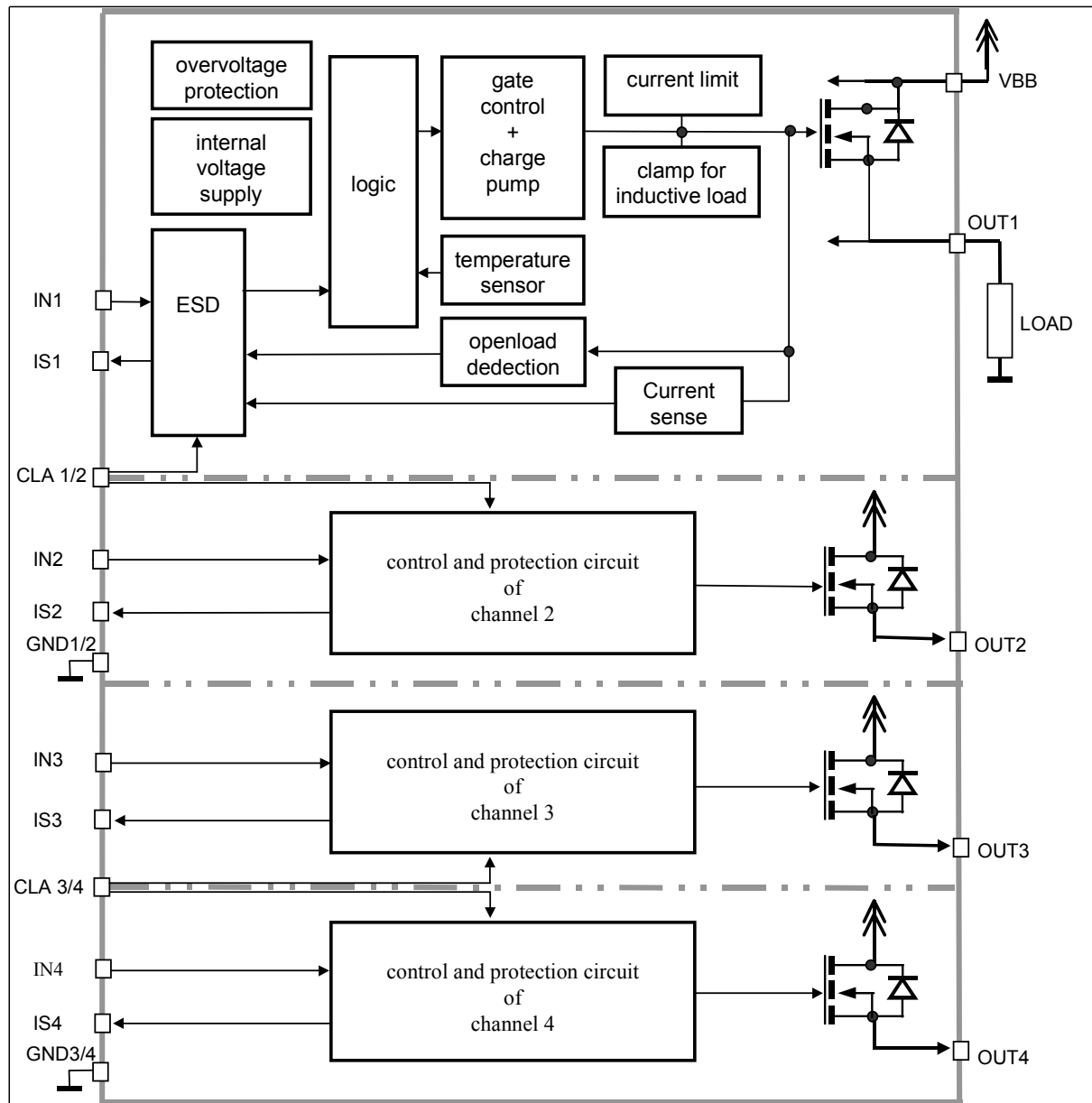
Diagnostic Functions: IntelliSense

- Proportional load current sense (with defined fault signal during thermal shutdown and overload)
- Additional open load detection in OFF - state
- Suppressed thermal toggling of fault signal

Block Diagram



Functional diagram



Pin definition and function

Pin	Symbol	Function
1,14, 15,28	V _{bb}	Positive power supply voltage. Design the wiring for the simultaneous max. short circuit currents from channel 1 to 4 and also for low thermal resistance
3	IN1	Input 1,2,3,4 activates channel 1,2,3,4 in case of logic high signal
6	IN2	
9	IN3	
12	IN4	
25,26,27	OUT1	Output 1,2,3,4 protected high-side power output of channel 1,2,3,4. Design the wiring for the max. short circuit current
22,23,24	OUT2	
19,20,21	OUT3	
16,17,18	OUT4	
4	IS1	Diagnostic feedback 1...4 of channel 1 to 4 On state: advanced current sense with defined signal in case of overload or short circuit Off state: High on failure
5	IS2	
10	IS3	
11	IS4	
7	CLA 1/2	Current limit adjust; the current limit for channels 1/2 and 3/4 can be chosen as high (potential < 2V) or low (potential > 4V).
13	CLA 3/4	
2	GND 1/2	Ground of chip 1 (channel 1,2)
8	GND 3/4	Ground of chip 2 (channel 3,4)

Pin configuration

(top view)		
V _{bb}	1 ●	28 V _{bb}
GND ½	2	27 OUT1
IN1	3	26 OUT1
IS1	4	25 OUT1
IS2	5	24 OUT2
IN2	6	23 OUT2
CLA ½	7	22 OUT2
GND ¾	8	21 OUT3
IN3	9	20 OUT3
IS3	10	19 OUT3
IS4	11	18 OUT4
IN4	12	17 OUT4
CLA ¾	13	16 OUT4
V _{bb}	14	15 V _{bb}

Maximum Ratings at $T_j=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Value	Unit
Supply voltage (overvoltage protection see page 6)	V_{bb}	28 ¹⁾	V
Supply voltage for full short circuit protection; $T_j = -40\dots150^\circ\text{C}$	$V_{bb(SC)}$	28 ²⁾	
Maximum voltage across DMOS	V_{ON}	52	
Load dump protection ³⁾ $V_{LoadDump} = V_A + V_S$; $V_A = 13,5\text{ V}$ In = low or high; $t_d = 400\text{ ms}$; R_l ⁴⁾ = $2\ \Omega$ $R_L = 2.25\ \Omega$ $R_L = 6.8\ \Omega$	$V_{LoadDump}$	40 53	
Load current (Short - circuit current, see page 7)	I_L	$I_{L(lim)}$ ⁵⁾	A
Operating temperature range	T_j	$-40\dots+150$	$^\circ\text{C}$
Storage temperature range	T_{stg}	$-55\dots+150$	
Dynamical temperature rise at switching	dT	60	K
Power dissipation ⁶⁾ (DC), all channels active $T_A = 85\ ^\circ\text{C}$	P_{tot}	1,6	W
Maximal switchable inductance, single pulse $V_{bb}=12\text{V}$, $T_{jstart}=150^\circ\text{C}$; (see diagrams on page 12) $I_L = 6\text{ A}$, $E_{AS} = 0.319\text{ J}$, $R_L = 0\ \Omega$, one channel: $I_L = 12\text{ A}$, $E_{AS} = 0.679\text{ J}$, $R_L = 0\ \Omega$, two parallel channels:	$Z_{L(s)}$	9.8 5.2	mH
Electrostatic discharge voltage IN: (Human Body Model) IS: according to ANSI EOS/ESD - S5.1 - 1993 , ESD STM5.1 - 1998 OUT:	V_{ESD}	1,0 2,0 4,0	
Continuous input voltage	V_{IN}	$-10\dots16$	V
Voltage at current limit adjustment pin	V_{CLA}	$-10\dots16$	
Current through current limit adjustment pin	I_{CLA}	± 5.0	mA
Current through input pin (DC)	I_{IN}	± 5.0	
Current through sense pin (DC) (see page 11)	I_{IS}	$-5\dots+10$	

¹ 18...28 V for 100 hours

² only single pulse, $R_L = 200\text{ m}\Omega$; $L = 8\ \mu\text{H}$; R and L are describing the complete circuit impedance including line, contact and generator impedances.

³ Supply voltage higher than $V_{bb(AZ)}$ require an external current limit for the GND ($150\ \Omega$ resistor) and sense pin.

⁴ R_l = internal resistance of the load dump test pulse generator.

⁵ Current limit is a protection function. Operation in current limitation is considered as "outside" normal operating range. Protection functions are not designed for continuous repetitive operation.

⁶ Device on 50mm*50mm*1.5mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for V_{bb} connection. PCB is vertical without blown air.

Electrical Characteristics

Parameter and Conditions, each of the four channels at $T_j = -40...+150\text{ }^{\circ}\text{C}$, $V_{bb} = 9...16\text{ V}$, unless otherwise specified	Symbol	Values			Unit
		min.	typ.	max.	

Thermal Resistance

junction - soldering point ¹⁾	each channel:	R_{thJS}	-	-	25	K/W
junction - ambient ²⁾	one channel active:	R_{thJA}	-	40	-	K/W
	all channels active:			32		

Load Switching Capabilities and Characteristics

On-state resistance (V_{bb} to OUT), (see page 13) $T_j = 25\text{ }^{\circ}\text{C}$, $I_L = 5\text{ A}$, $T_j = 150\text{ }^{\circ}\text{C}$, $T_j = 25\text{ }^{\circ}\text{C}$, $T_j = 25\text{ }^{\circ}\text{C}$,	each channel: each channel: two parallel channels: four parallel channels:	R_{ON}	- - - -	21 42 11 5.5	25 50 13 6.5	$m\Omega$
Nominal load current ²⁾ $T_a = 85^{\circ}\text{C}$, $T_j \leq 150^{\circ}\text{C}$,	one channel active: two channels active, per channel: four channels active, per channel:	$I_{L(nom)}$	5.7 4.0 3.1	6.2 4.4 3.4	- - -	A
Output voltage drop limitation at small load currents $I_L = 0.5\text{ A}$		$V_{ON(NL)}$	-	40	-	mV
Output current while GND disconnected ³⁾ (see diagram page 12) $V_{IN} = 0\text{ V}$		$I_{L(GNDhigh)}$	-	-	2	mA

¹Soldering point is measured at V_{bb} -pin

²Device on 50mm*50mm*1.5mm epoxy PCB FR4 with 6 cm² (one layer, 70μm thick) copper area for V_{bb} connection. PCB is vertical without blown air.

³not subject to production test, specified by design

Electrical Characteristics

Parameter and Conditions, each of the four channels at $T_j = -40...+150\text{ °C}$, $V_{bb} = 9...16\text{ V}$, unless otherwise specified	Symbol	Values			Unit
		min.	typ.	max.	

Load Switching Capabilities and Characteristics

Turn-on time ¹⁾ to 90% V_{OUT} $R_L = 12\text{ }\Omega$, $V_{bb} = 12\text{ V}$	t_{on}	-	90	200	μs
Turn-off time ¹⁾ to 10% V_{OUT} $R_L = 12\text{ }\Omega$, $V_{bb} = 12\text{ V}$	t_{off}	-	100	220	
Slew rate on ¹⁾ 10 to 30% V_{OUT} , $R_L = 12\text{ }\Omega$, $V_{bb} = 12\text{ V}$	dV/dt_{on}	0.1	0.25	0.45	$\text{V}/\mu\text{s}$
Slew rate off ¹⁾ 70 to 40% V_{OUT} , $R_L = 12\text{ }\Omega$, $V_{bb} = 12\text{ V}$	$-dV/dt_{off}$	0.09	0.25	0.4	

Operating Parameters

Operating voltage ²⁾	$V_{bb(on)}$	4.5	-	28	V
Overvoltage protection ³⁾ $I_{bb} = 40\text{ mA}$	$V_{bb(AZ)}$	41	47	52	
Standby current ⁴⁾ (see diagram on page 13) $T_j = -40...+25\text{ °C}$, $V_{IN} = 0\text{ V}$ $T_j = 150\text{ °C}$	$I_{bb(off)}$	-	10	15	μA
		-	-	40	

¹See timing diagram on page 14.

²18V...28V for 100 hours

³Supply voltages higher than $V_{bb(AZ)}$ require an external current limit for the status pin and GND pin (e.g. 150Ω).
See also $V_{Out(CL)}$ in table of protection functions and circuit diagram on page 11.

⁴Measured with load; for the whole device; all channels off.

Electrical Characteristics

Parameter and Conditions, each of the four channels at $T_j = -40...+150\text{ }^{\circ}\text{C}$, $V_{bb} = 9...16\text{ V}$, unless otherwise specified	Symbol	Values			Unit
		min.	typ.	max.	
Diagnostic Characteristics					
Open load detection voltage	$V_{\text{OUT(OL)}}$	2	3.2	4.4	V
Internal output pull down ¹⁾ $V_{\text{OUT}} = 13.5\text{ V}$	$R_{\text{OUT(PD)}}$	11	23	35	kΩ
Current sense ratio, static on-condition $k_{\text{ILIS}} = I_{\text{L}}:I_{\text{IS}}$ $I_{\text{L}} = 0.5\text{ A}$ $I_{\text{L}} = 3\text{ A}$ $I_{\text{L}} = 6\text{ A}$	k_{ILIS}	4640 4900 4900	5800 5400 5350	6960 5900 5800	
Sense signal in case of fault-conditions ²⁾ in off-state	V_{fault}	5	6.2	7.5	V
Current saturation of sense fault signal	I_{fault}	4	-	-	mA
Sense signal delay after thermal shutdown ³⁾	$t_{\text{delay(fault)}}$	-	-	1.2	ms
Current sense output voltage limitation $I_{\text{IS}} = 0$, $I_{\text{L}} = 5\text{ A}$	$V_{\text{IS(lim)}}$	5.4	6.5	7.3	V
Current sense leakage/offset current $V_{\text{IN}} = 5\text{ V}$, $I_{\text{L}} = 0$, $V_{\text{IS}} = 0$	$I_{\text{IS(LH)}}$	-	-	5	μA
Current sense settling time to I_{IS} static ±10% after positive input slope ⁴⁾ , $I_{\text{L}} = 0$ to 5A	$t_{\text{son(IS)}}$	-	-	400	μs
Current sense settling time to I_{IS} static ±10% after change of load current ⁴⁾ , $I_{\text{L}} = 2.5$ to 5A	$t_{\text{slc(IS)}}$	-	-	300	

¹⁾In case of floating output, the status doesn't show open load.

²⁾Fault condition means output voltage exceeds open load detection voltage $V_{OUT(OL)}$

³⁾In the case of thermal shutdown the V_{fault} signal remains for $t_{delay(fault)}$ longer than the restart of the switch (see diagram on page 16). Not subject to production test, specified by design.

⁴⁾not subject to production test, specified by design

Electrical Characteristics

Parameter at $T_j = -40...+150\text{ }^\circ\text{C}$, $V_{bb} = 9...16\text{ V}$, unless otherwise specified	Symbol	Values			Unit
		min.	typ.	max.	

Diagnostic Characteristics

Status invalid after negative input slope	$t_{d(SToff)}$	-	-	1.2	ms
Status invalid after positive input slope with open load	$t_{d(STOL)}$	-	-	20	μs

Input Feedback¹⁾

Input resistance (see circuit page 11)	R_I	2.0	3.5	5.5	k Ω
Input turn-on threshold voltage	$V_{IN(T+)}$	-	-	2.4	V
Input turn-off threshold voltage	$V_{IN(T-)}$	1.0	-	-	
Input threshold hysteresis	$\Delta V_{IN(T)}$	-	0.5	-	
Off state input current $V_{IN} = 0.4\text{ V}$	$I_{IN(off)}$	3	-	40	μA
On state input current $V_{IN} = 5\text{ V}$	$I_{IN(on)}$	20	50	90	

Reverse Battery²⁾

Reverse battery voltage	$-V_{bb}$	-	-	27	V
Drain-source diode voltage ($V_{OUT} > V_{bb}$) $T_j = 150\text{ }^\circ\text{C}$, $I_{bb} = -10\text{ mA}$	$-V_{ON}$	-	330	-	mV

¹⁾ If ground resistors R_{GND} are used, add the voltage drop across these resistor.

²⁾ Requires a 150 Ω resistor in GND connection. The reverse load current through the intrinsic drain-source diode has to be limited by the connected load. Power dissipation is higher compared to normal operating conditions due to the voltage drop across the drain-source diode. The temperature protection is not active during reverse current operation! Input and status currents have to be limited. (see max. ratings page 4)

Truth Table - for each of the four channels

	Input level	Output level	Diagnostic output
Normal Operation	L H	L V_{bb}	$Z^{1)}$ $I_{IS} = I_L / \text{kilis}$
Current Limitation ²⁾	H	V_{bb}	V_{fault}
Short circuit to GND	L H	L L	$Z^{1)}$ V_{fault}
Overtemperature	L H	L L	$Z^{1)}$ V_{fault}
Short circuit to V_{bb}	L H	V_{bb} V_{bb}	V_{fault} $< I_{IS} = I_L / \text{kilis}^3)$
Open load	L H	$> V_{\text{out(OL)}}$ V_{bb}	V_{fault} $Z^{1)}$

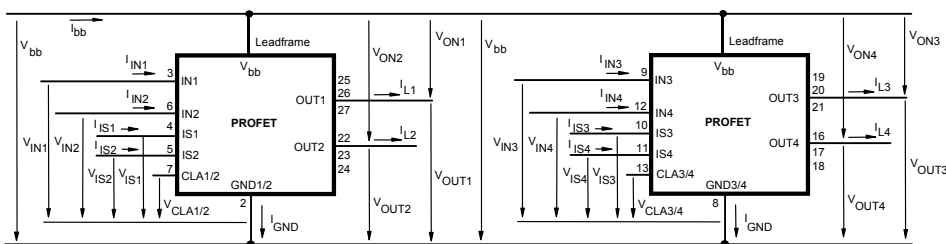
L = " Low" Level Z = high impedance, potential depends on external circuit

H = "High" Level $V_{\text{fault}} = 5V$ typ., constant voltage independent of external sense resistor.

Parallel switching of channels is possible by connecting the inputs and outputs parallel.

The current sense outputs have to be connected with a single sense resistor.

Terms



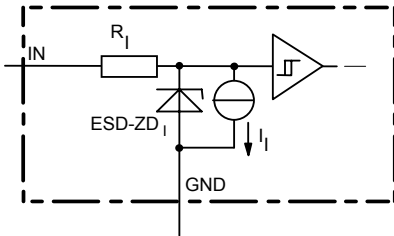
Leadframe (V_{bb}) is connected to pin 1, 14, 15, 28

¹L-potential by using a sense resistor

²Current limitation is only possible while the device is switched on.

³Low ohmic short to V_{bb} may reduce the output current I_L and therefore also the sense current I_{IS} .

Input circuit (ESD protection), IN1...IN4



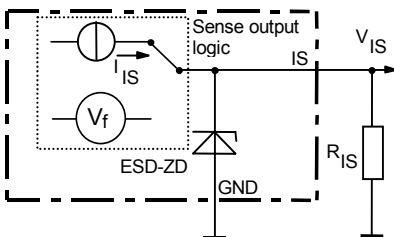
The use of ESD zener diodes as voltage clamp at DC conditions is not recommended.

Sense-Status output, IS1...IS4

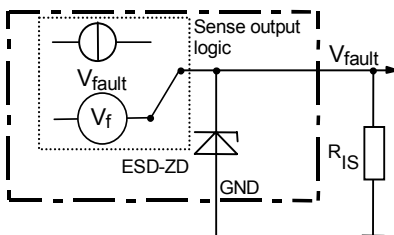
ON-State: Normal operation: $I_S = I_L / \text{kILIS}$

$$V_{IS} = I_S * R_{IS}; \quad R_{IS} = 1\text{k}\Omega \text{ nominal}$$

$$R_{IS} > 500\Omega$$



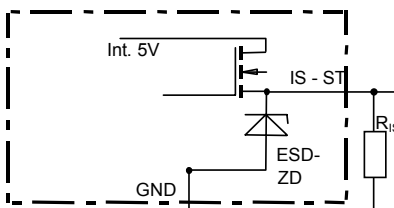
ESD zener diode: $V_{ESD} = 6,1 \text{ V typ.}, \text{ max. } 14 \text{ mA}$;
ON-State: Fault condition so as thermal shut down or current limitation



$V_{\text{fault}} = 6 \text{ V typ}$; $V_{\text{fault}} < V_{ESD}$ under all conditions

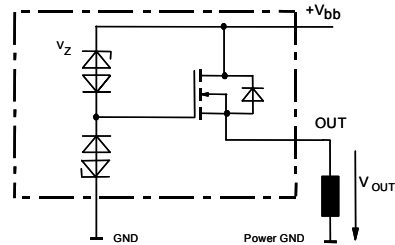
OFF-State diagnostic condition:

Open Load, if $V_{OUT} > 3 \text{ V typ.}$; IN low



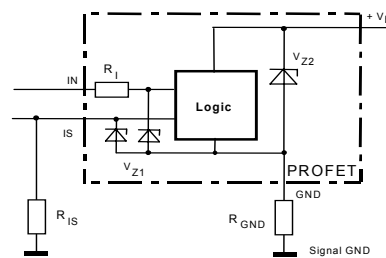
ESD-Zener diode: $6,1\text{V typ.}, \text{ max. } 5\text{mA}$; $R_{ST(ON)} < 375\Omega$
at $1,6\text{mA}$.. The use of ESD zener diodes as voltage clamp at DC conditions is not recommended.

Inductive and overvoltage output clamp, OUT1...OUT4



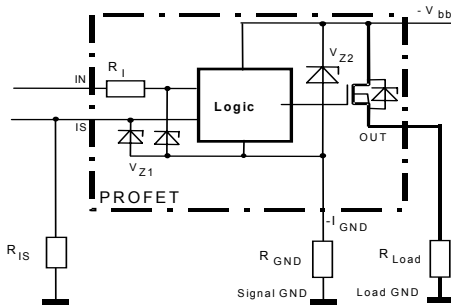
V_{Out} clamped to $V_{\text{Out(CL)}} = -15 \text{ V typ.}$

Overvolt. Protection of logic part OUT1...OUT4



$V_{Z1} = 6,1\text{V typ.}, V_{Z2} = 47\text{V typ.}, R_{GND} = 150\Omega$,
 $R_{IS} = 1\text{k}\Omega$, $R_I = 3,5\text{k}\Omega \text{ typ.}$

Reverse battery protection OUT1...OUT4

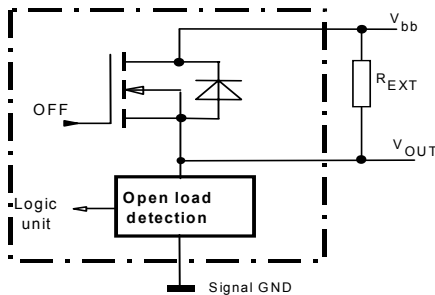


$V_{Z1} = 6,1V$ typ., $V_{Z2} = 47V$ typ., $R_{GND} = 150\Omega$
 $R_{IS} = 1k\Omega$, $R_I = 3,5k\Omega$ typ.

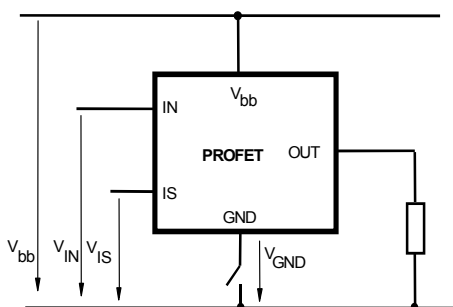
In case of reverse battery the load current has to be limited by the load. Protection functions are not active.

Open load detection, OUT1...OUT4

Off-state diagnostic condition:
 Open load, if $V_{OUT} > 3V$ typ.; $IN = low$

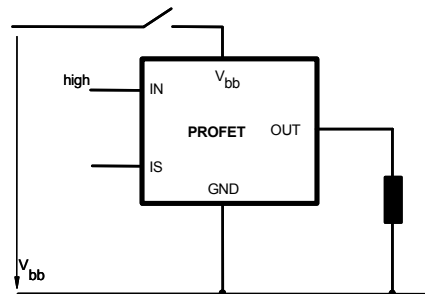


GND disconnect



Any kind of load.

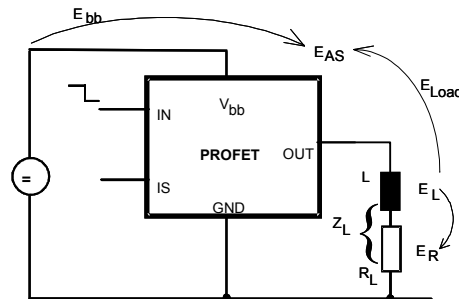
Vbb disconnect with energized inductive load



For inductive load currents up to the limits defined by Z_L each switch is protected against loss of V_{bb} . (max. ratings and diagram on page 12)

Consider at your PCB layout that in the case of V_{bb} disconnection with energized inductive load all the load current flows through the GND connection.

Inductive load switch-off energy dissipation



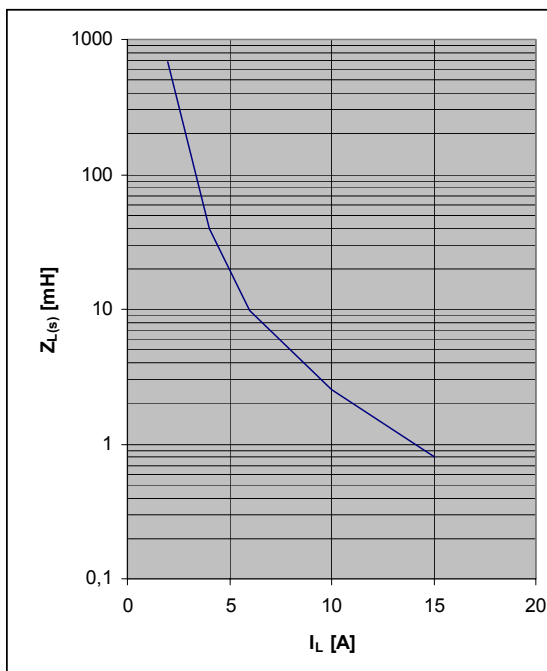
Energy stored in load inductance: $E_L = \frac{1}{2} * L * I_L^2$

While demagnetizing load inductance, the energy dissipated in PROFET is
 $E_{AS} = E_{bb} + E_L - E_R = V_{ON(CL)} * i_L(t) dt$,
 with an approximate solution for $R_L > 0\Omega$:

$$E_{AS} = \frac{I_L * L}{2 * R_L} * (V_{bb} + |V_{OUT(CL)}|) * \ln(1 + \frac{I_L * R_L}{|V_{OUT(CL)}|})$$

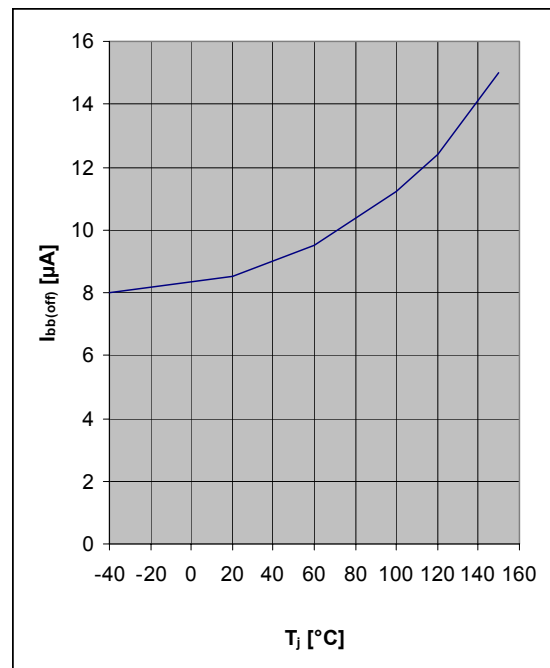
**Maximum allowable load inductance
for a single switch off (one channel)**

$L = f(I_L)$; $T_{jstart} = 150^\circ\text{C}$, $V_{bb} = 12\text{V}$, $R_L = 0\Omega$



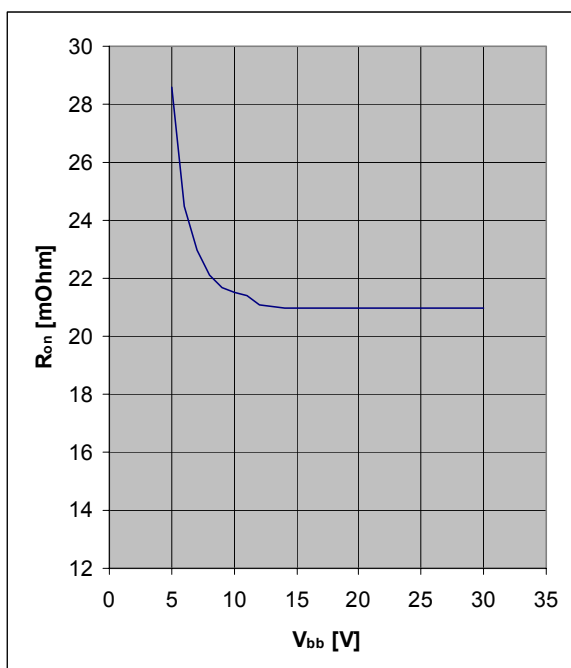
Typ. standby current

$I_{bb(off)} = f(T_j)$; $V_{bb} = 16\text{V}$; $V_{IN1...4} = \text{low}$



Typ. on-state resistance

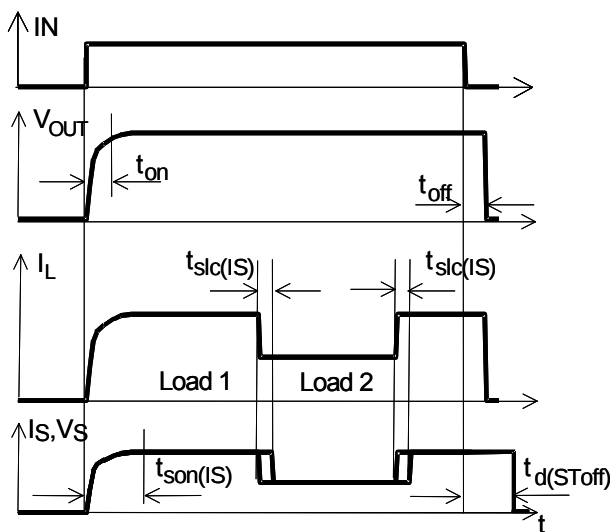
$R_{ON} = f(V_{bb}, T_j)$; $I_L = 5\text{A}$; $V_{in} = \text{high}$



Timing diagrams

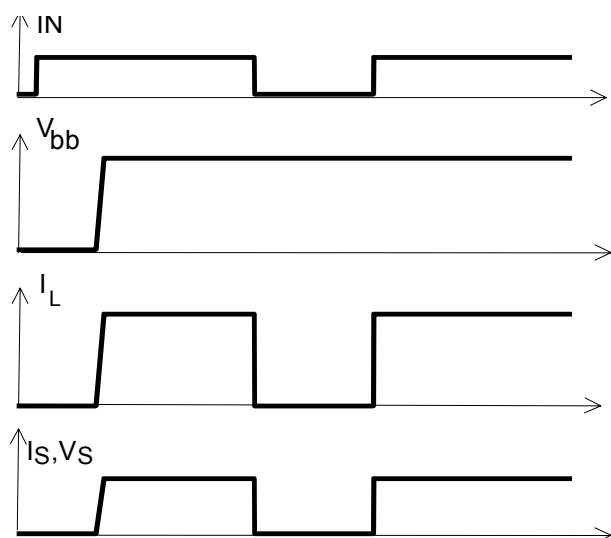
All channels are symmetric and consequently the diagrams are valid for channel 1 to channel 4.

Figure 1a: Switching a resistive load, change of load current in on-condition



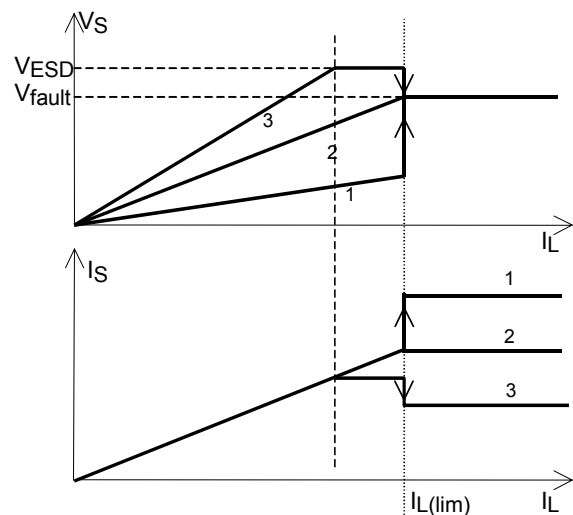
The sense signal is not valid during settling time after turn on or change of load current. $t_{slc}(I_S) = 300 \mu s$ max.

Figure 1b: V_{bb} turn on



proper turn on under all conditions

Figure 1c: Behaviour of sense output: Sense current (I_S) and sense voltage (V_S) as function of load current dependent on the sense resistor. Shown is V_S and I_S for three different sense resistors. Curve 1 refers to a low resistor, curve 2 to a medium-sized resistor and curve 3 to a big resistor. Note, that the sense resistor may not fall short of a minimum value of 500Ω .



$$I_S = I_L / k_{ILIS}$$

$$V_{IS} = I_S * R_{IS}; R_{IS} = 1k\Omega \text{ nominal}$$

$$R_{IS} > 500\Omega$$

Figure 2a: Switching a lamp

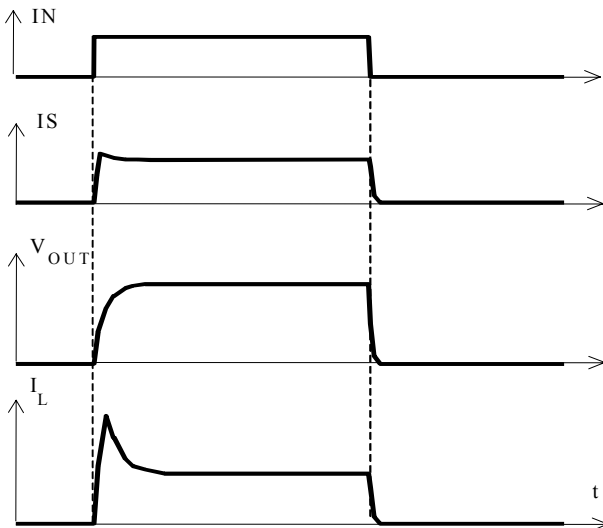


Figure 2b: Switching a lamp with current limit:
The behaviour of I_S and V_S is shown for a resistor, which refers to curve 1 in figure 1c

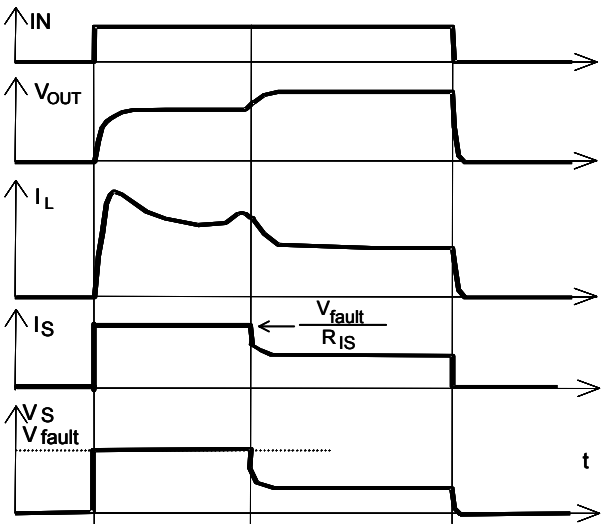
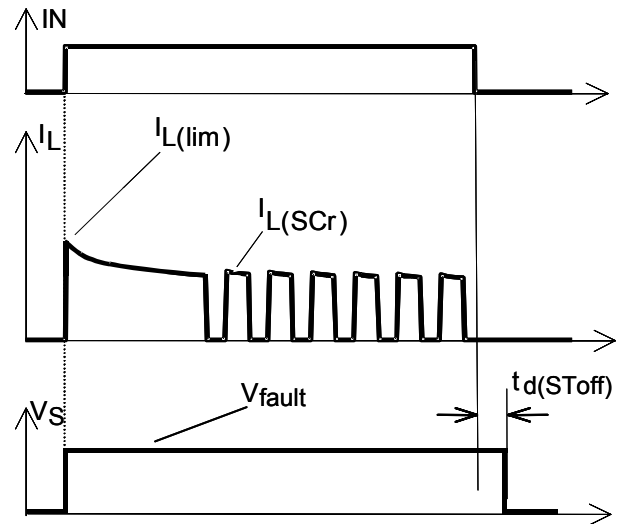


Figure 3a: Short circuit:
Shut down by overtemperature,
reset by cooling



Heating up may require several milliseconds, depending on external conditions.
 $I_{L(lim)} = 50A$ typ. increases with decreasing temperature.

Figure 3b: Turn on into short circuit,
shut down by overtemperature, restart by cooling
(channel 1 and 2 switched parallel)

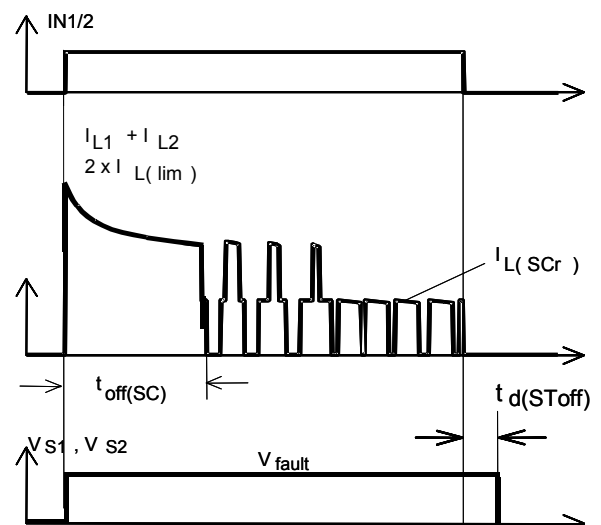


Figure 4a: Overtemperature

Reset if $T_j < T_{jt}$

The behaviour of I_S and V_S is shown for a resistor, which refers to curve 1 in figure 1c.

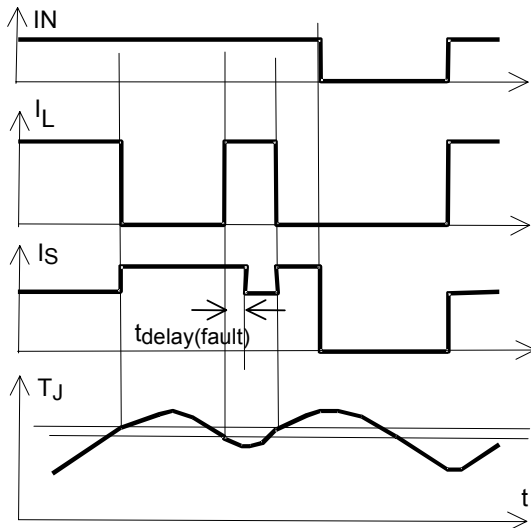


Figure 6a: Current sense ratio¹⁾

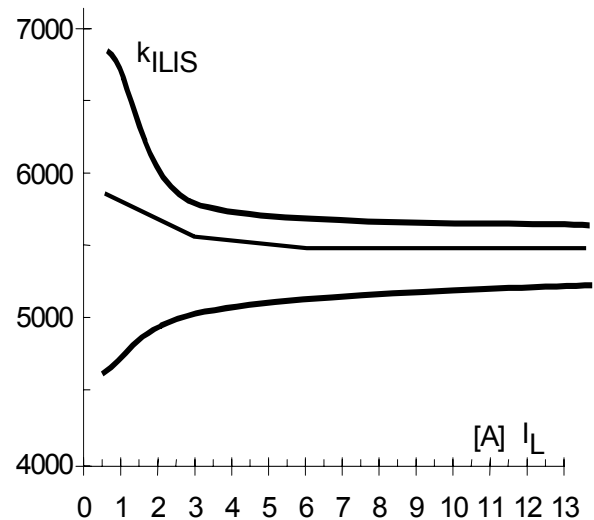
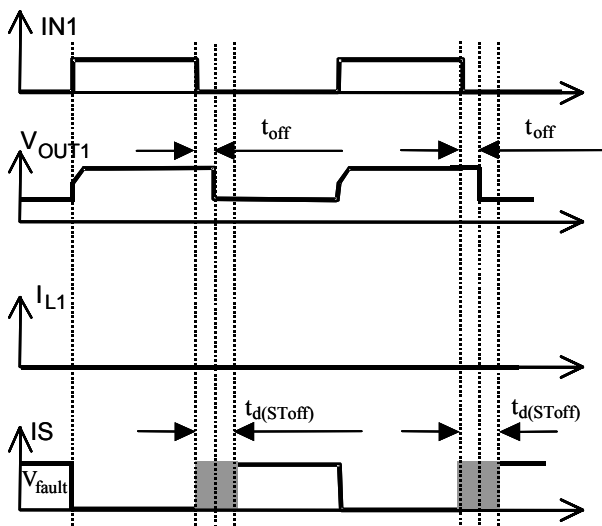


Figure 5a: Open-load: detection in OFF-state, turn on/off to open load.

Open load of channel 1; other channels normal operation.



$t_{off} = 220\mu s$ max.; $t_d(SToff) = 1,2ms$ max.

with pull up resistor at output

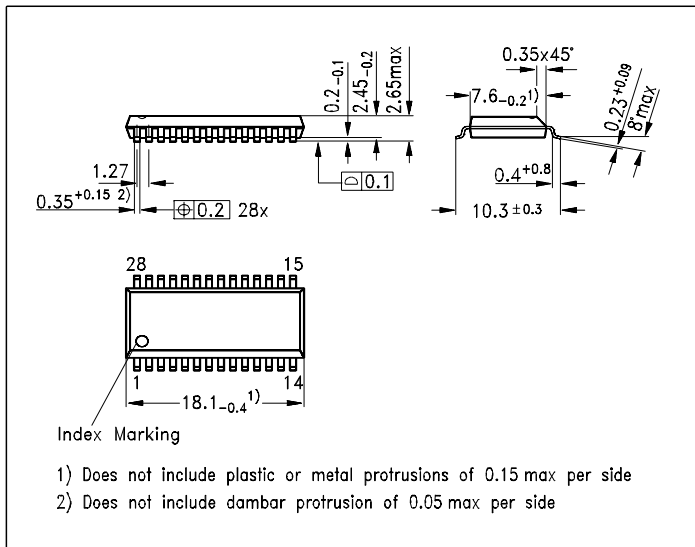
¹⁾ This range for the current sense ratio refers to all devices. The accuracy of the k_{ILIS} can be raised by calibrating the value of k_{ILIS} for every single device.

Package and ordering code

all dimensions in mm

P-DSO-28-19

Sales Code	BTS 5440G
Ordering Code	Q67060-S6136



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